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PATENT & TRADEMARK OFFICE

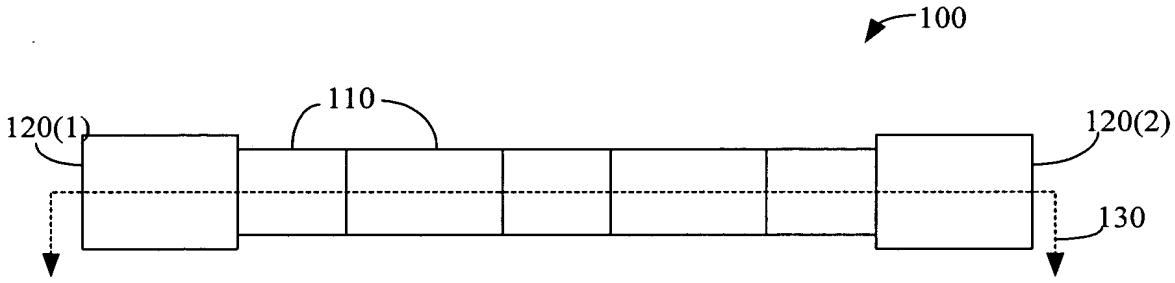


Figure 1A

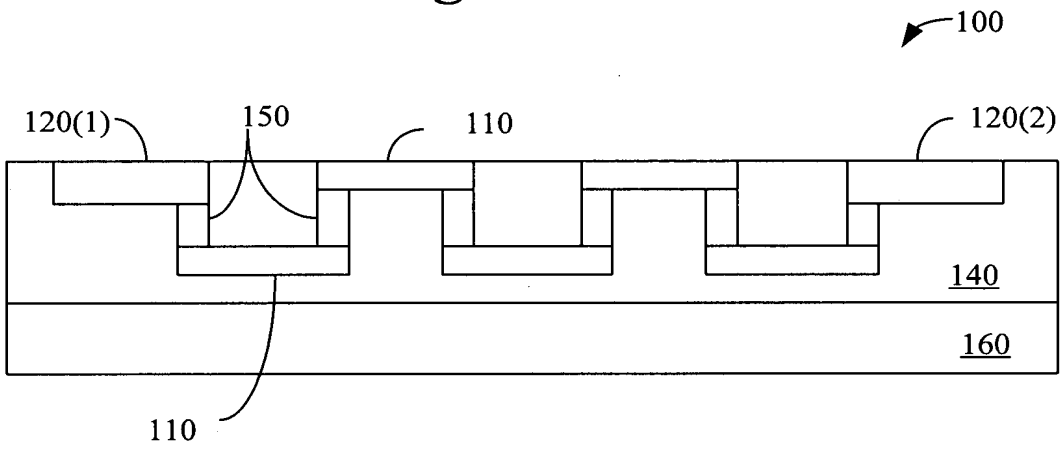


Figure 1B

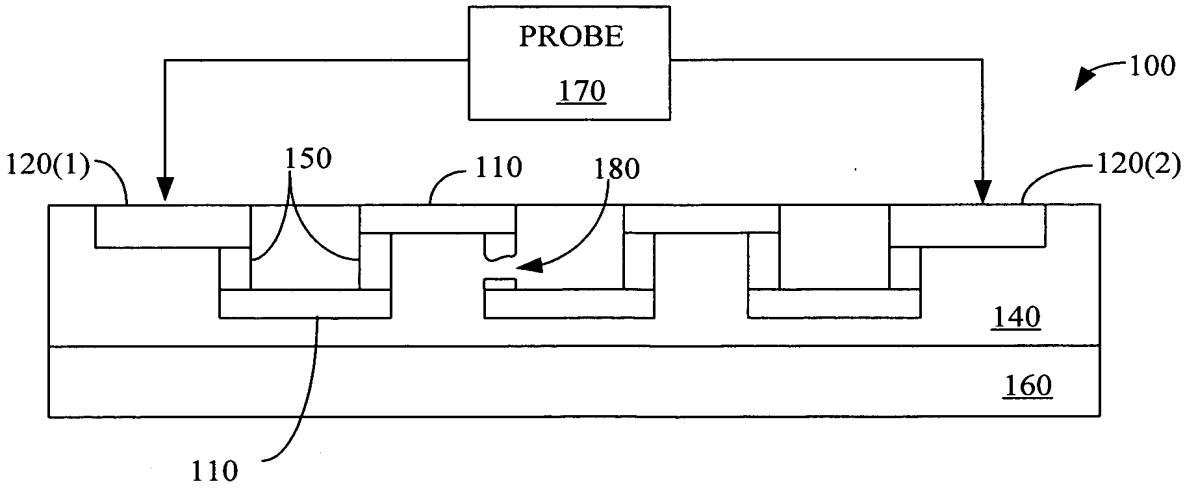


Figure 1C

(Prior Art)

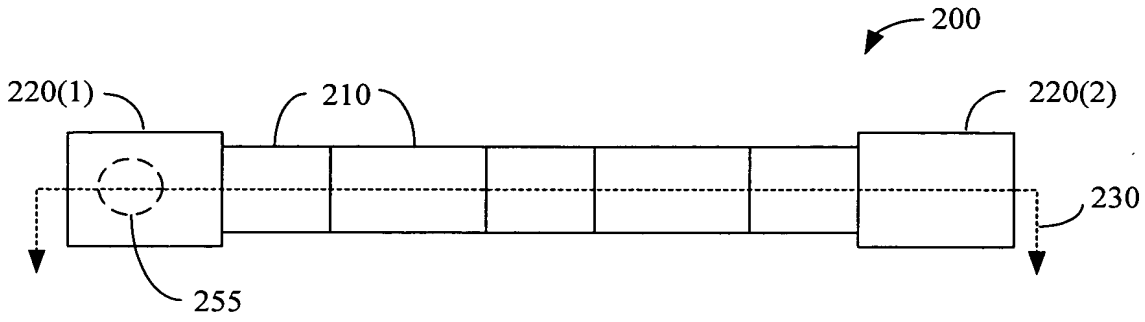


Figure 2A

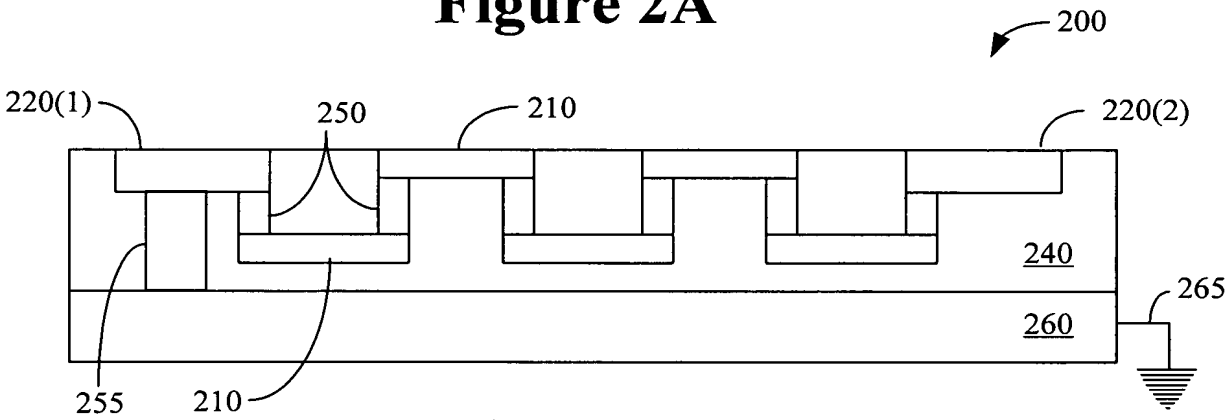


Figure 2B

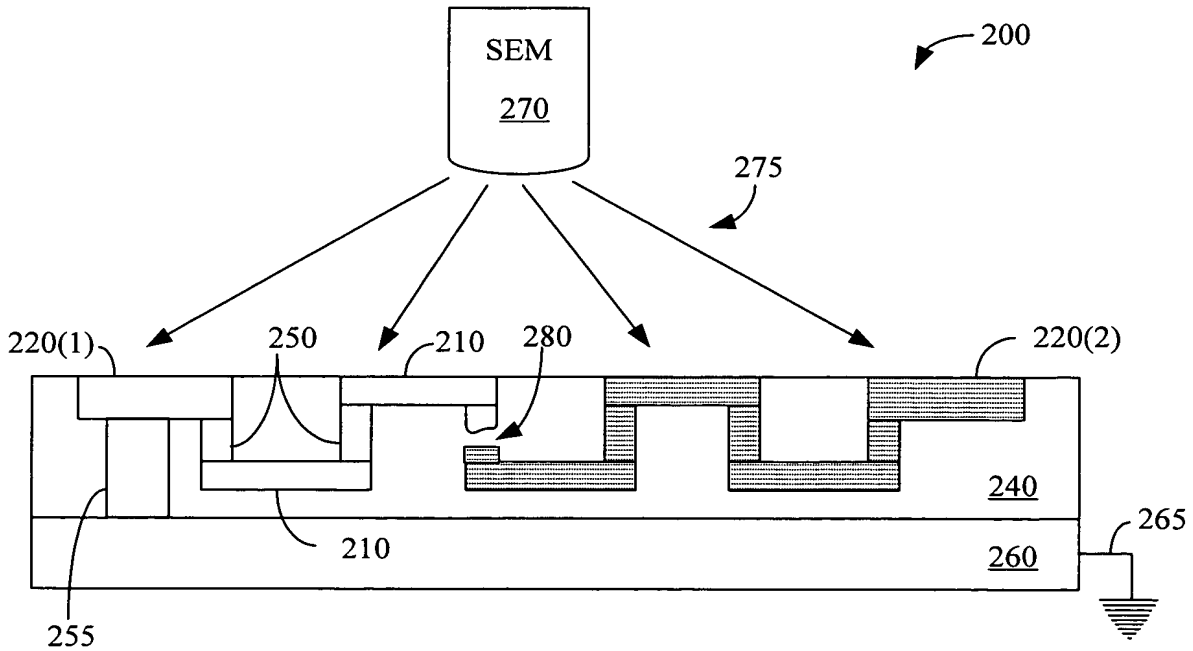
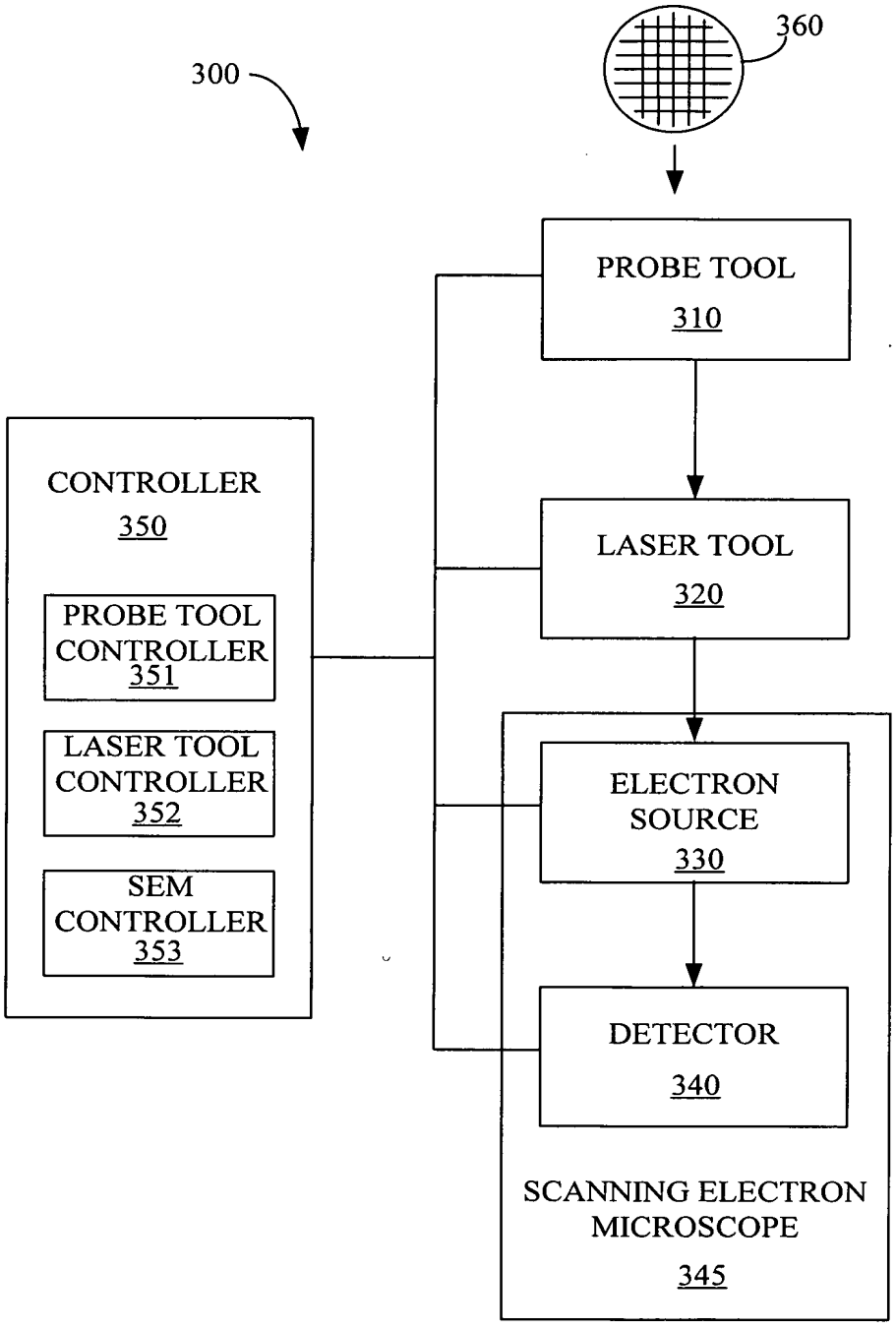


Figure 2C

(Prior Art)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LASER TOOL
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ELECTRON
SOURCE
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DETECTOR
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SCANNING ELECTRON
MICROSCOPE
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CONTROLLER
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PROBE TOOL
CONTROLLER
351
LASER TOOL
CONTROLLER
352
SEM
CONTROLLER
353

Figure 3

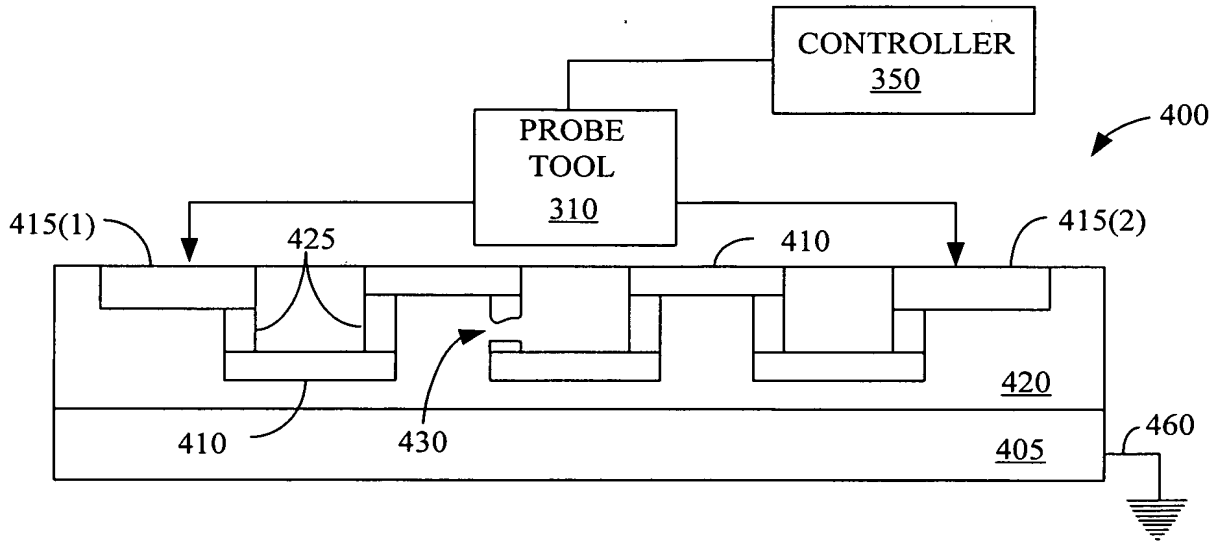

Figure 4A

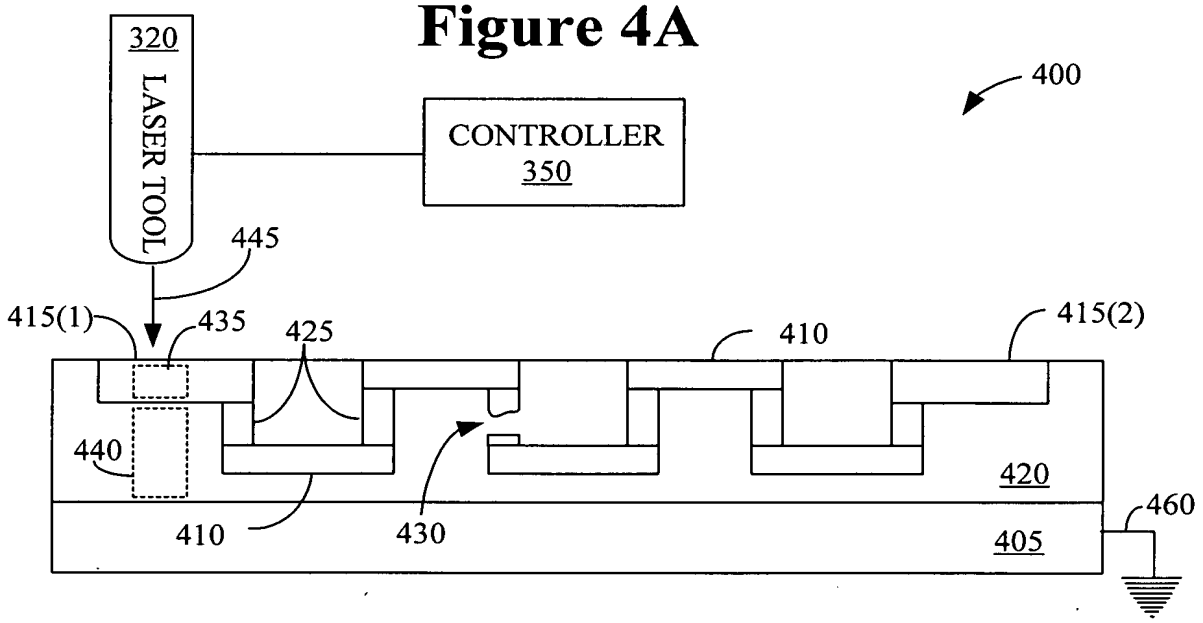

Figure 4B

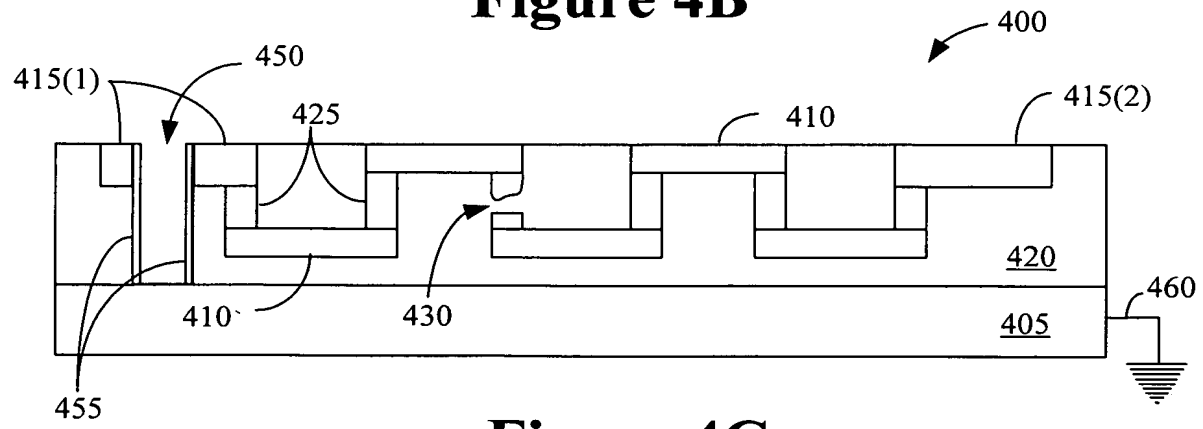

Figure 4C

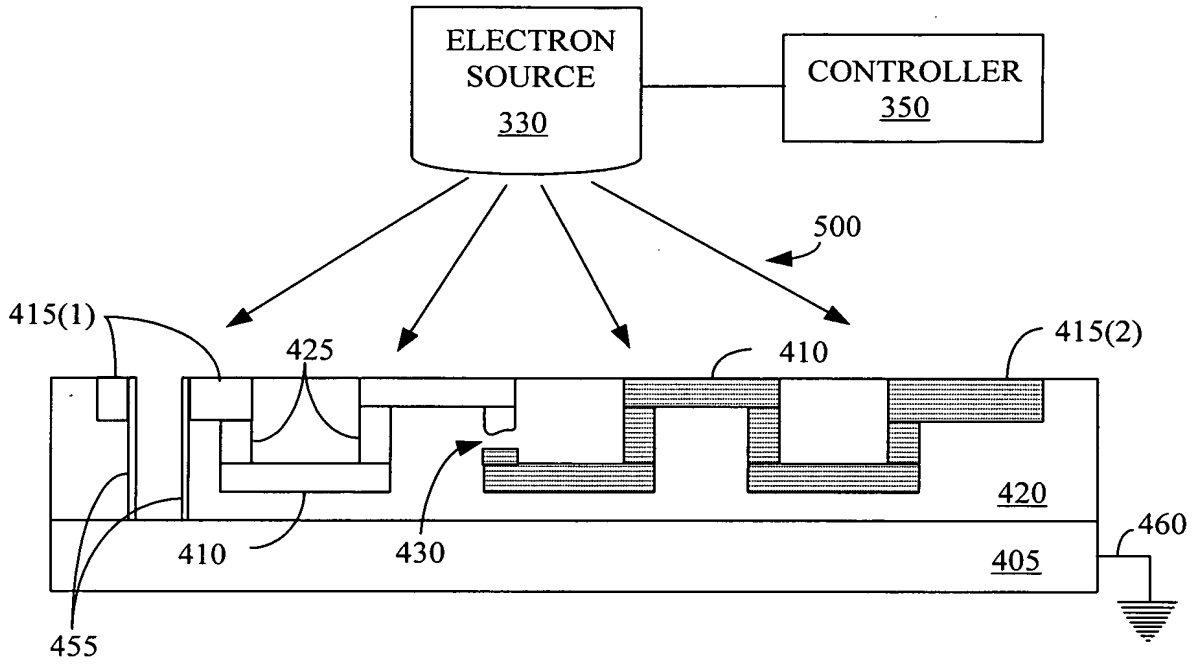

Figure 5A

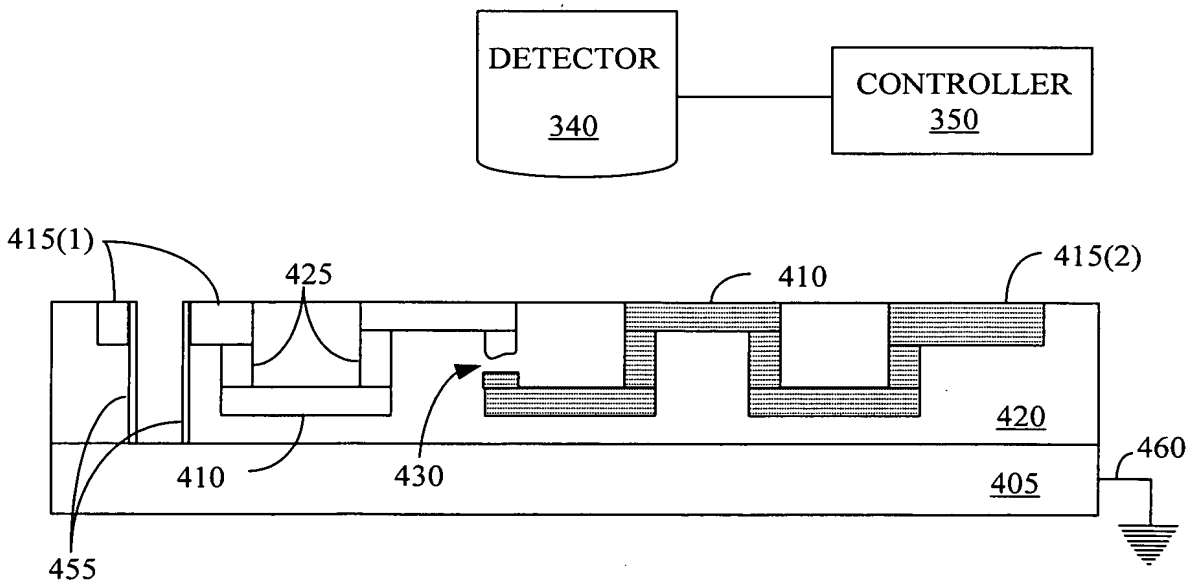

Figure 5B

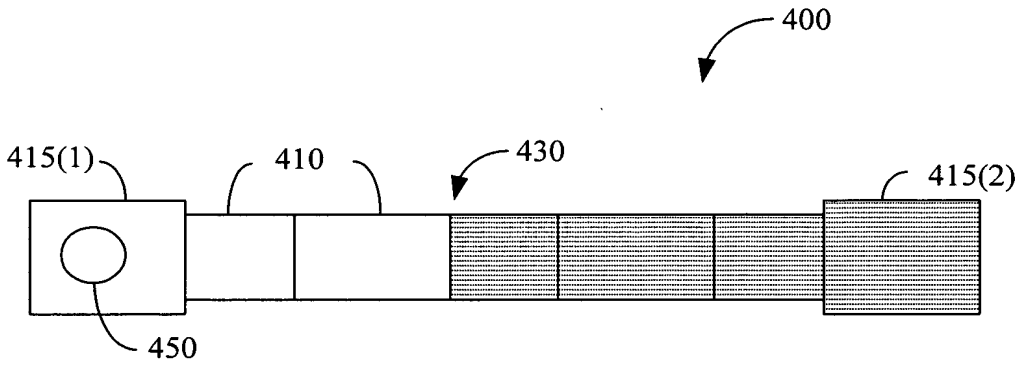

Figure 6

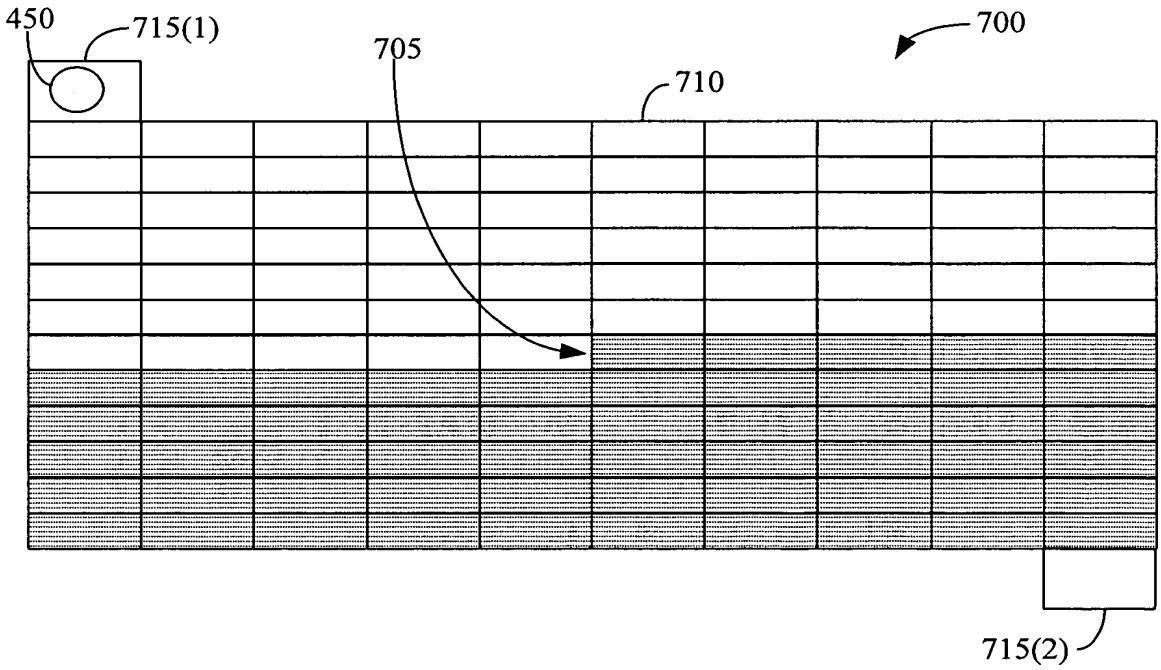

Figure 7